

MoTiC: Prototype of a Depleted Monolithic Pixel Detector with Timing

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MoTiC is a prototype of a Depleted Monolithic Active Pixel Sensor capable of time measurements. The chip is produced in a modified LFoundry 110 nm process with a pixel pitch of $50\ \mu\text{m} \times 50\ \mu\text{m}$ and three active thicknesses of 48, 100 and $200\ \mu\text{m}$. The chip comprises a number of different amplifier and sensor designs for evaluation. MoTiC was characterized with particle beams before irradiation. The characterization results presented in this paper demonstrate that a hit detection efficiency in excess of 99.8%, a spatial resolution better than $5\ \mu\text{m}$ and a coarse timing resolution better than 1.2 ns are achieved.

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1. Introduction

The high-energy physics group of the Paul Scherrer Institute (PSI) in collaboration with ETH Zürich has a generic R&D program for Depleted Monolithic Active Pixel Sensors (DMAPS) since 2019. The goal of this program is to develop position sensitive particle detectors capable of time measurements for possible applications at PSI in-house low-energy physics experiments. The aim is to develop detectors with a hit detection efficiency higher than 99 % before irradiation, a spatial resolution better than 10 μm and a timing resolution better than 1 ns.

The Monolithic Timing Chip, MoTiC, is produced in a modified LFoundry 110 nm CMOS process. The process modification and sensing elements have been developed by the ARCADIA collaboration [1, 2]. MoTiC features a pixel pitch of 50 μm \times 50 μm and comes in two variants:

- MoTiC A: comprises of 5120 pixels arranged in 80 columns and 64 rows. There are 7 different amplifiers in different sections of the chip while all pixels have identical sensors;
- MoTiC B: has 3840 pixels arranged in 80 columns and 48 rows. It comprises 5 different sensor designs. Four sensors designs have the same amplifier while one is AC coupled with a different amplifier.

The chip and amplifier designs are described in [3].

2. Characterization with Particle Beams

Non-irradiated chips have been tested with 4 GeV electrons at room temperature at beam line 24 of the DESY test beam facility [4]. A beam telescope consisting of six planes of ALPIDE [5] sensors were used for track reconstruction. The beam test data were analyzed using the Corryvreckan framework [6].

2.1 Hit Detection Efficiency

Hit detection efficiency of a chip is defined as

$$\epsilon_{hit} = \frac{N_{hit}}{N_t}, \quad (1)$$

where N_{hit} is the number of reconstructed tracks traversing the chip with a corresponding hit in the chip and N_t is the total number of tracks passing through the chip. Many envisaged applications require a hit detection efficiency $\epsilon_{hit} > 99\%$ at vertical incidence at room temperature before irradiation.

The inefficiencies of 200 μm thick MoTiC A and MoTiC B chips are shown in Fig. 1a and 1b, respectively. All amplifier and sensor variants reach an efficiency in excess of 99.8 % for a bias voltage of 60 V at vertical incidence. Fig. 1c and 1d show hit efficiency as a function of bias voltage for MoTiC A and MoTiC B. MoTiC A reaches the maximum efficiency at bias voltages greater than 55 V. All sensor variants of MoTiC B reach the maximum hit detection efficiency at bias voltages above 50 V except the AC coupled variant which needs only 40 V to reach the maximum efficiency. This is expected since owing to the AC coupling the collection electrode can be biased to voltages different than the fixed voltage of DC coupled electrodes.

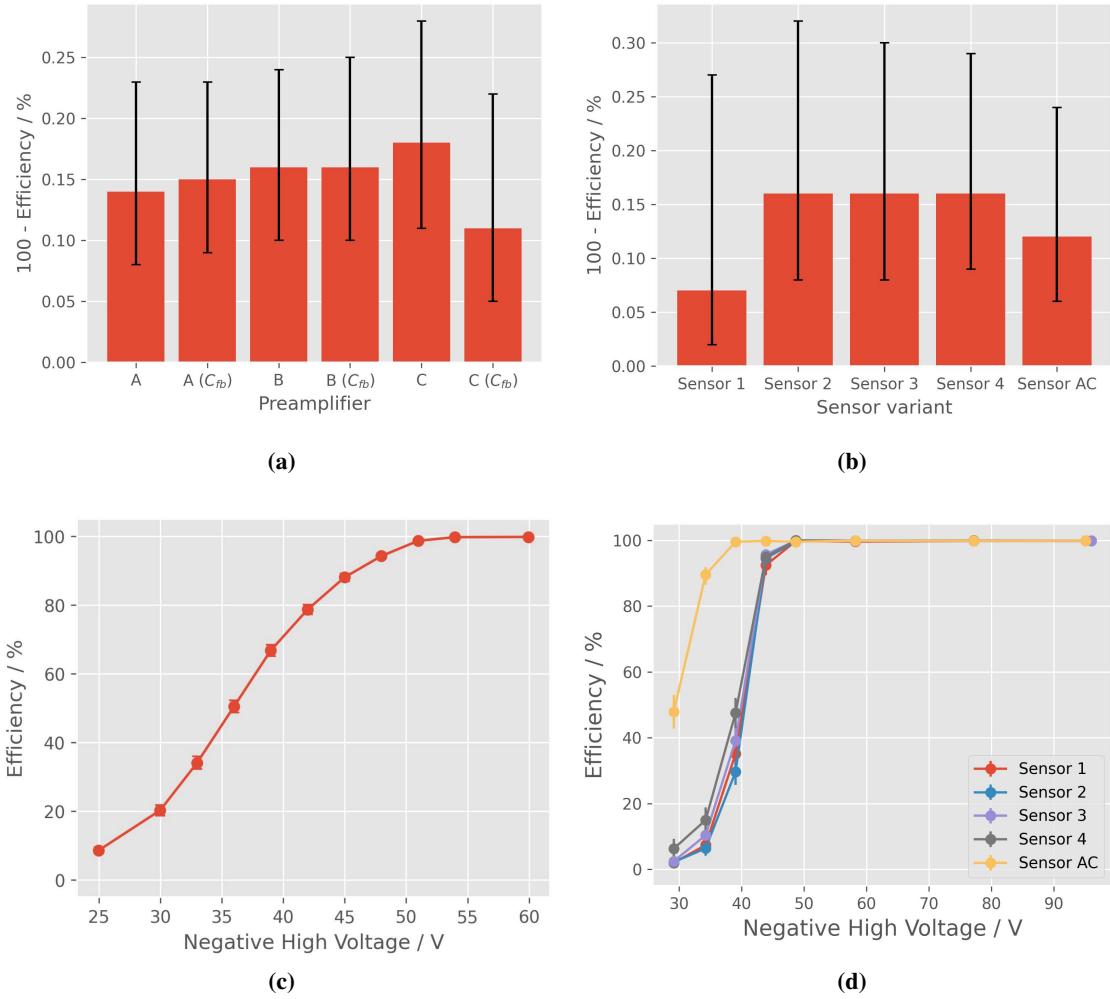


Figure 1: Hit detection inefficiency of 200 μm thick (a) MoTiC A and (b) MoTiC B. Hit detection efficiency as a function of bias voltage for (c) MoTiC A and (d) MoTiC B.

2.2 Spatial Resolution

To determine the spatial resolution of the assemblies a residual distribution is formed by subtracting the distance of a cluster in MoTiC to the impact point of the telescope track extrapolated to the position of MoTiC in each event. To suppress the deteriorating effect of outliers on the RMS of the residual distribution, a truncated RMS of the residual distribution is calculated by iteratively discarding entries outside of ± 6 RMS. The truncated RMS is taken to be the spatial resolution of the detector.

Fig. 2a shows the residual width as a function of angle of incidence for MoTiC A chips with different active thicknesses. Owing to high charge sharing even at vertical incidence in MoTiC as can be seen from cluster size distribution shown in Fig. 2b, the residual width at vertical incidence is better than the expected binary resolution in absence of charge sharing. After subtraction of 4.4 μm telescope resolution from the residual width, the best spatial resolution of 4.8 μm is obtained

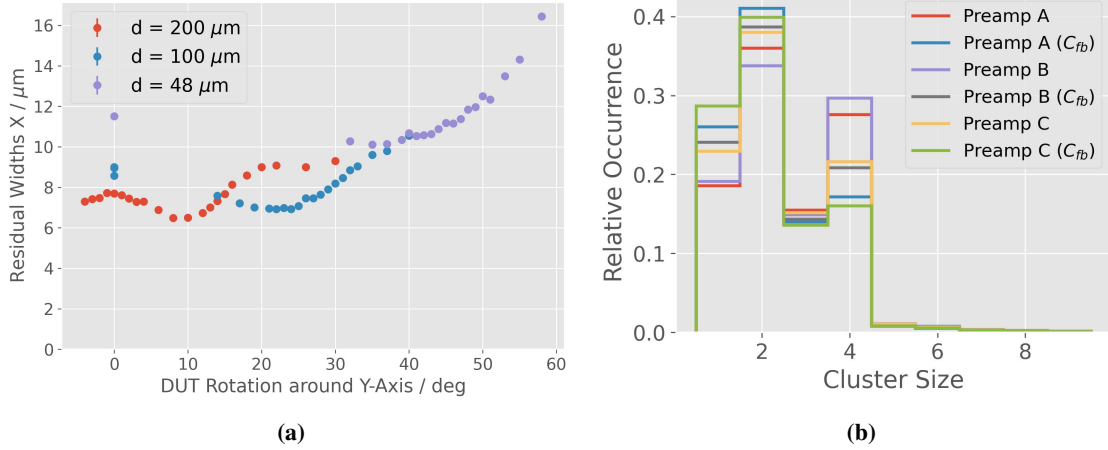


Figure 2: (a) Residual width as a function of angle of incidence for MoTiC A chips with different active thicknesses and (b) cluster size distribution of aplifier variants of MoTiC A.

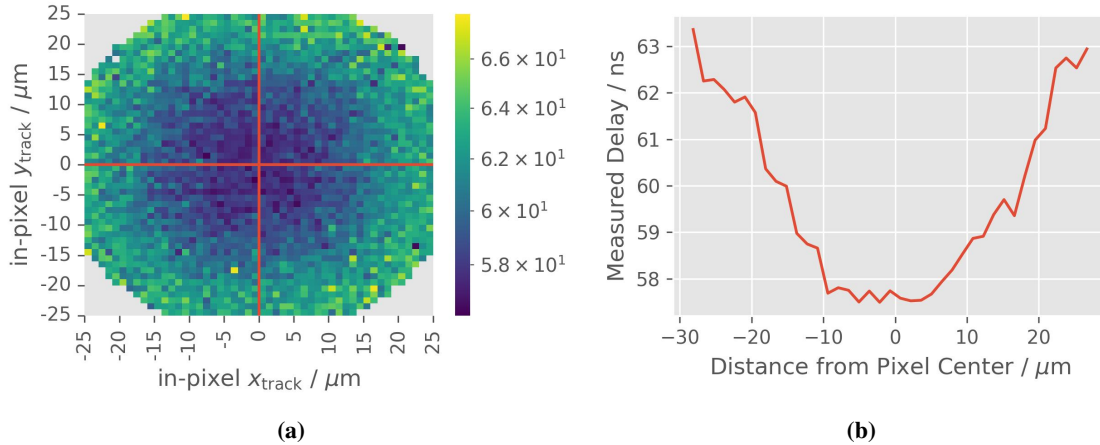


Figure 3: (a) In-pixel hit time measurement with MoTiC A and (b) its diagonal cross section.

with the sample with $200 \mu\text{m}$ active thickness at the optimal angle for 2-pixel clusters. Due to the high charge sharing mentioned above, the optimal angle is 8° which differs from expected $\tan^{-1}(50/200) \approx 14^\circ$. The measurements were taken at a bias voltage of 60 V. The high charge sharing is due to low field regions below the pixel edges as demonstrated by simulations in [2].

2.3 Timing Resolution

Every four pixels of MoTiC share a TDC. The TDC unit measures time of a hit using a combination of a coarse digital and a fine analog measurement. Calibration measurements demonstrated that the TDC unit has a timing resolution better than 40 ps. Hit time measurements with particle beams was performed using the hit as the start signal for time measurement and a signal from a dedicated trigger system as the stop. Fig. 3 shows in-pixel coarse digital time measurement. Hits in the central region of the pixel have shorter drift time owing to the higher electric field. Fine analog

timing was not available due to technical reasons. A coarse timing resolution better than 1.2 ns was achieved.

3. Conclusions

MoTiC, a new fully depleted monolithic pixel chip capable of timing measurements, has been developed and characterized with particle beams. The chip has reached an hit detection efficiency in excess of 99.8 % before irradiation. A hit resolution of 4.8 μm is obtained at an optimal angle for 2-pixel clusters. The in-pixel TDC has reached a fine timing resolution better than 40 ps when characterized with test pulses while only coarse timing measurement was characterized with particle beams and reached a timing resolution better than 1.2 ns.

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